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# Compact Modeling of Nonlinearities in Submicron MOSFETs

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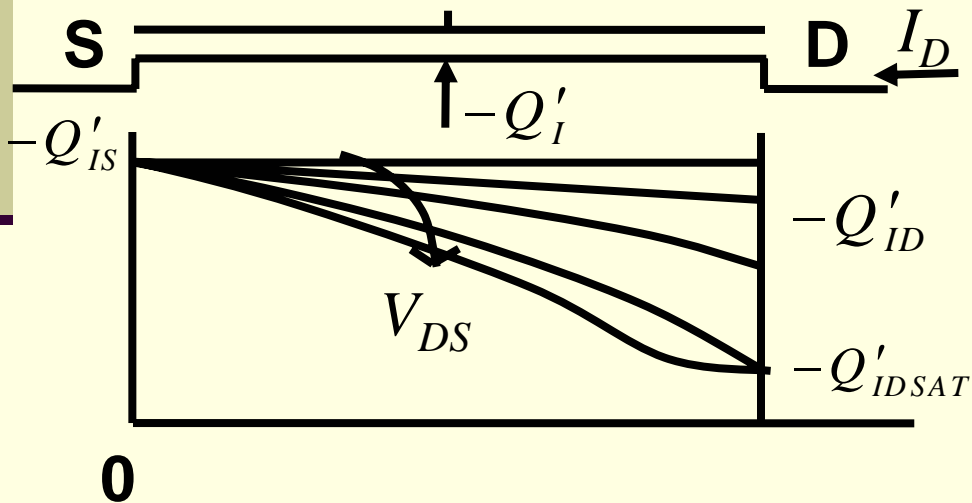
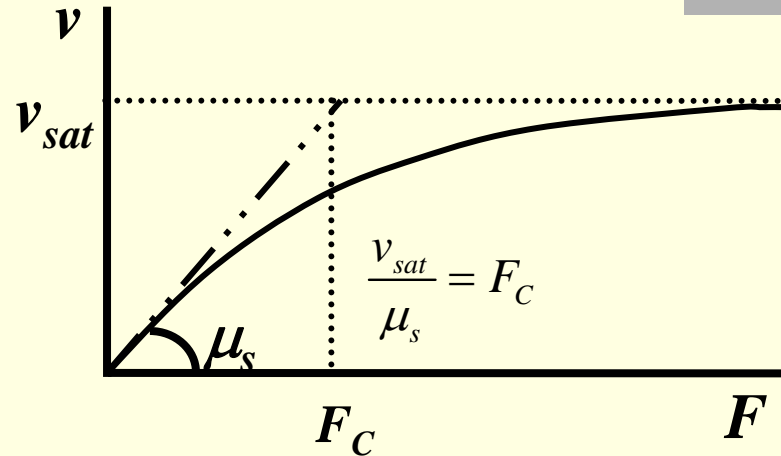
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# Mobility model

$$\mu = \frac{\mu_s}{1 - \frac{F}{F_c}} = \frac{\mu_s}{1 - \frac{\mu_s F}{v_{sat}}}$$



**Saturation:** The minimum amount of electron charge flowing at the saturation velocity, required to sustain the current is

$$Q'_{IDSAT} = -I_D / Wv_{sat}$$

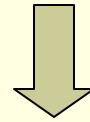
# Basic dc Equations

$$\mu = \frac{\mu_s}{1 - \frac{F}{F_c}} = \frac{\mu_s}{1 - \frac{\mu_s F}{v_{sat}}}$$

$$V_P - V_C = \phi_t [q'_I - 1 + \ln(q'_I)]$$

$$dQ'_I = nC'_{ox} d\phi_s$$

$$I_D = -\mu W Q'_I \frac{dV_C}{dy}$$



$$i_{Dsat} = \frac{(q'_{IS} + q'_{IDSat} + 2)}{1 + \varepsilon (q'_{IS} - q'_{IDSat})} (q'_{IS} - q'_{IDSat}) = \frac{2}{\varepsilon} q'_{IDSat}$$

$$q'_I = \frac{Q'_I}{(-nC'_{ox}\phi_t)}$$

$$i_D = \frac{I_D}{I_S}$$

$\varepsilon$ : short-channel factor

$$I_S = \frac{\mu_s C'_{ox} n \phi_t^2}{2} \frac{W}{L}$$

$$\varepsilon = \frac{\mu_s \phi_t / L}{v_{sat}}$$

# Transconductance and 2nd order derivative

$$g_{mg} = \frac{2I_S}{n\phi_t} \frac{q'_{IS}}{2 + \varepsilon q'_{IS}} \left[ \frac{4 + \varepsilon q'_{IS}}{2 + \varepsilon q'_{IS}} \right]$$

$$g''_{mg} = \frac{d^3 I_D}{dV_G^3} = \frac{2I_S}{(n\phi_t)^3} \frac{q'_{IS}}{(q'_{IS} + 1)^3} \frac{1 - \varepsilon q'_{IS} - 1.5\varepsilon q'_{IS}^2}{(1 + \varepsilon q'_{IS} / 2)^4}$$

long-channel
short-channel effect

$$g''_{mg}$$

# Experimental results

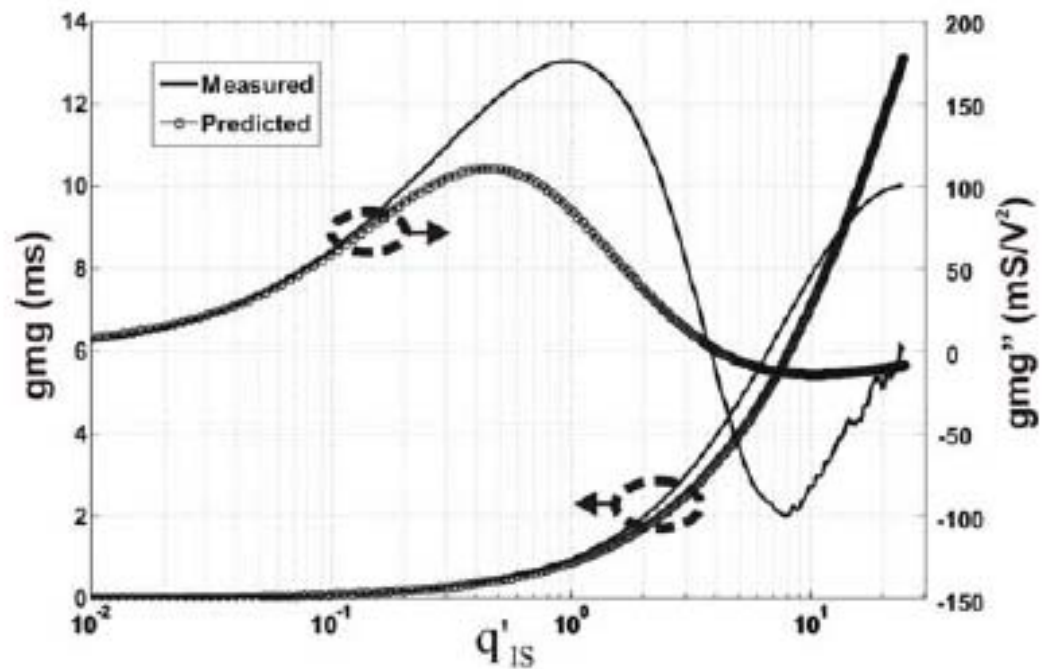


Figure 3: Predicted and measured  $gm$  and  $gm''$  for a  $W(20\mu m)/L(0.2\mu m)$  transistor in the TSMC 0.18 process.

# Experimental results

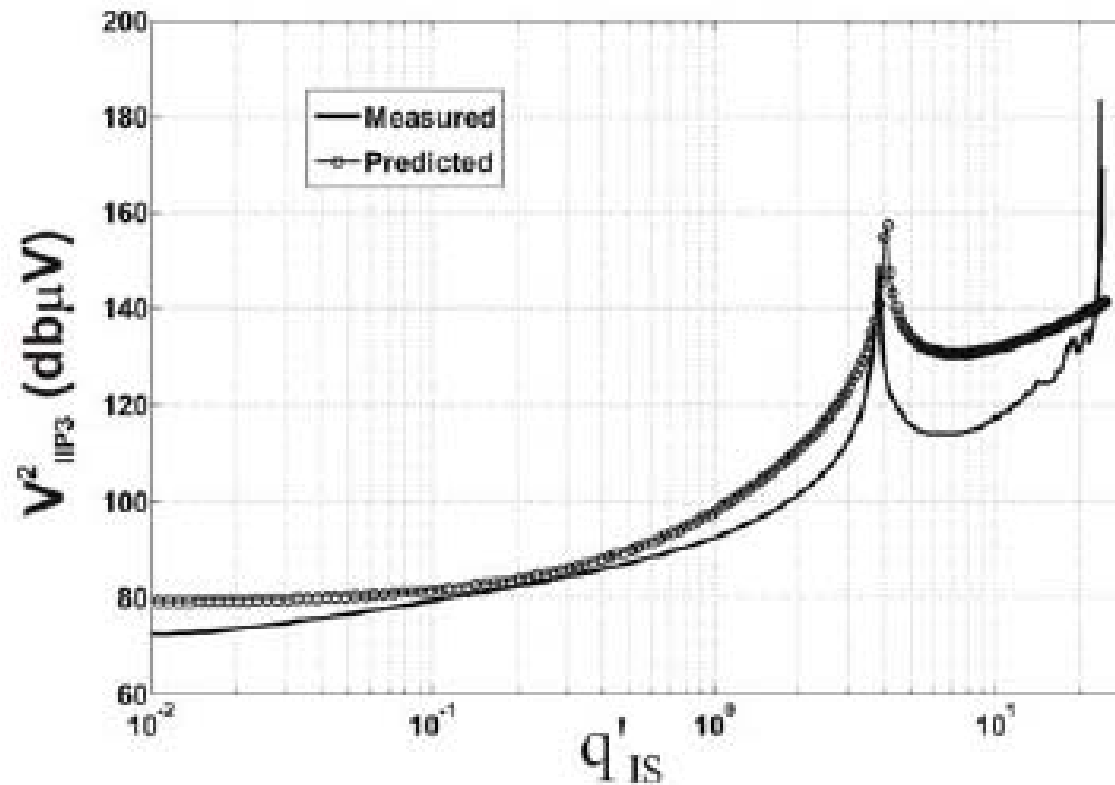


Figure 4: Predicted and measured  $V^2_{IP3}$  as a function of the normalized charge density in the source

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- Velocity saturation degrades transconductance but reduces third order harmonic distortion
  - Simple equations derived using charge-based model
  - Approximations allow first order calculation of IP3